

RF Test Report

For

Applicant Name: Micron Electronics LLC.

Address: 1001 Yamato Road Suite 400 Boca Raton, Flonda 33431 United

States

EUT Name: WB100

Brand Name:

Model Number: WB100

Issued By

Company Name: BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park,

Address: Tantou Community, Songgang Street, Bao'an District, Shenzhen,

China

Report Number: BTF230815R00201 Test Standards: 47 CFR Part 15.247

Test Conclusion: Pass

FCC ID: ZKQ-WB100

Test Date: 2023-06-30 to 2023-07-14

Date of Issue: 2023-07-30

Prepared By: Elma Kang

elma.yang / Project Engine

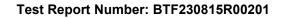
Date: 2023-07-30

Approved By:

Ryan.CJ / EMC Manager

Date: 2023-07-30

Note: All the test results in this report only related to the testing samples. Which can be duplicated completely for the legal use with approval of applicant; it shall not be reproduced except in full without the written approval of BTF Testing Lab (Shenzhen) Co., Ltd., All the objections should be raised within thirty days from the date of issue. To validate the report, you can contact us.





Revision History				
Version	Issue Date	Revisions Content		
R_V0	2023-07-30	Original		
Note:	Once the revision has l	Once the revision has been made, then previous versions reports are invalid.		

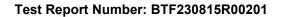
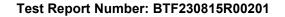




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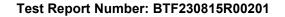


1 Test Summary

Test Item	Section in CFR 47	Result	
RF Output Power	Part 2.1046	Pass	
	Part 22.913(d)		
Peak-To-Average Ratio	Part 24.232 (d)	Pass	
	Part 27.50(d)(5)		
Modulation Characteristics	Part 2.1047	N/A	
99% & -26 dB Occupied Bandwidth	Part 2.1049	Pass	
	Part 2.1051		
	Part 22.917		
Spurious Emissions at Antenna Terminal	Part 24.238	Pass	
	Part 27.53(g)		
	Part 27.53(h)		
	Part 2.1053		
	Part 22.917		
Field Strength of Spurious Radiation	Part 24.238	Pass	
	Part 27.53(g)		
	Part 27.53(h)		
	Part 22.913(a)		
ERP,EIRP	Part 24.232(c)	Pass	
ERF,EIRF	Part 27.50(c)	F455	
	Part 27.50(d)		
	Part 2.1051		
	Part 22.917		
Out of band emission, Band Edge	Part 24.238	Pass	
Out of band emission, band Edge	Part 27.53(g)	F 433	
	Part 27.53(h)		
	Part 2.1055(a)(1)(b)		
Frequency stability vs. temperature	Part 22.355	Pass	
requericy stability vs. temperature	Part 24.235	1 433	
	Part 27.54		
	Part 2.1055(d)(1)(2)		
Frequency stability vs. voltage	Part 22.355	Pass	
	Part 24.235		
	Part 27.54		

Note: 1. Pass: The EUT complies with the essential requirements in the standard.

^{2.} The conclusion of this test report is judged by actual test data without considering measurement uncertainty.





2 General Information

2.1 General Description of EUT

Description of Device (EUT)

EUT Name : WB100

Model No. : WB100

DIFF. : /

Power supply : DV 3.8V by battery or DC 5V by USB

Support Bands : LTE Band 2/4/5/12/66

Channel Bandwidth : LTE Band 2: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz

LTE Band 4: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz

LTE Band 5: 1.4MHz, 3MHz, 5MHz, 10MHz LTE Band 12: 1.4MHz, 3MHz, 5MHz, 10MHz

LTE Band 66: 1.4MHz, 3MHz, 5MHz, 10MHz, 15MHz, 20MHz

TX Frequency : LTE Band 2: 1850 ~ 1910 MHz

LTE Band 4: 1710 ~ 1755 MHz LTE Band 5: 824 ~ 849 MHz LTE Band 12: 699MHz ~ 716MHz LTE Band 66: 1710MHz ~ 1780MHz

Modulation type : QPSK, 16QAM

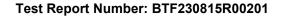
Antenna Type : Internal antenna, Antenna information is provided by applicant.

LTE Band 2: Maximum Gain is 0.37 dBi. LTE Band 4: Maximum Gain is 0.35 dBi LTE Band 5: Maximum Gain is -0.13 dBi LTE Band 12: Maximum Gain is -0.12 dBi. LTE Band 66:Maximum Gain is 0.36 dBi

Software version : WB01 V

Hardware version : WB01v01.01b05.00

Remark 1: The worst-case simultaneous transmission configuration was evaluated with no non-compliance found. Results in this report are only for 4G function, and there is no other transmitter involved.





2.2 Related Submittal(s) / Grant (s)

This submittal(s) (test report) is filing to comply with Section Part 22 subpart H and Part 24 subpart E of the FCC CFR 47 Rules.

2.3 Test Facility

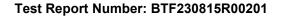
Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.	
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China	
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China	
FCC Registration Number:	518915	
Designation Number:	CN1330	
Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.	

2.4 Tested Supporting System Details

No.	Description	Manufacturer	Model	Serial Number	Certification or SDoC
				<u>-</u>	-

2.5 Test Conditions

Items	Required	Actual
Temperature range:	15-35°C	24°C
Humidity range:	25-75%	56%
Pressure range:	86-106kPa	98kPa

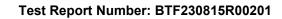




2.6 Measurement Uncertainty

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2 and TR100 028-1/-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
RF output power, conducted	0.63 dB
Conducted spurious emissions	0.94 dB
Radiated emissions (<1 GHz)	4.12 dB
Radiated emissions (>1 GHz)	4.16 dB
Occupied Channel Bandwidth	69 KHz
Frequency Stability	0.4 KHz
Temperature	0.82 °C
Humidity	4.1 %

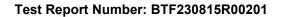




Test Instruments list 3

Conducted Method Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022.11.24	2023.11.23	\boxtimes
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022.11.24	2023.11.23	\boxtimes
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022.11.24	2023.11.23	\boxtimes
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022.11.24	2023.11.23	\boxtimes
RF Sensor Unit	Techy	TR1029-2	1	2022.11.24	2023.11.23	\boxtimes
RF Control Unit	Techy	TR1029-1	/	2022.11.24	2023.11.23	\boxtimes
RFTest software	1	V1.00	/	1	1	\boxtimes

Radiated Method Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
SIGNAL ANALYZER	ROHDE&SCHWARZ	FSQ40	100010	2022.11.24	2023.11.23	\boxtimes
EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCI7	101032	2022.11.24	2023.11.23	\boxtimes
Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2021.11.28	2023.11.27	\boxtimes
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2021.11.28	2023.11.27	\boxtimes
POSITIONAL CONTROLLER	SKET	PCI-GPIB	1	1	1	\boxtimes
RE Cable	REBES Talent	UF2-NMNM- 10m	21101570	2022.11.24	2023.11.23	\boxtimes
RE Cable	REBES Talent	UF1- SMASMAM- 10m	21101566	2022.11.24	2023.11.23	\boxtimes
RE Cable	REBES Talent	UF2-NMNM- 2.5m	21101573	2022.11.24	2023.11.23	\boxtimes
RE Cable	REBES Talent	UF2-NMNM- 1m	21101576	2022.11.24	2023.11.23	\boxtimes
RE Cable	REBES Talent	UF1- SMASMAM- 1m	21101568	2022.11.24	2023.11.23	\boxtimes
RE Cable	REBES Talent	UF2-NMNM- 10m	21101570	2022.11.24	2023.11.23	\boxtimes
RE Cable	REBES Talent	UF1- SMASMAM- 10m	21101566	2022.11.24	2023.11.23	\boxtimes





Preamplifier	SCHWARZBECK	BBV9744	00246	2022.11.24	2023.11.23	\boxtimes
Horn Antenna	Schwarzbeck	BBHA9120D	2597	2022.5.22	2024.5.21	\boxtimes
Coaxial cable Multiflex 141	Schwarzbeck	N/SMA 0.5m	517386	2023.3.24	2024.3.23	\boxtimes
Broadband Preamplilifier	Schwarzbeck	BBV9718D	80000	2023.3.24	2024.3.23	\boxtimes
Preamplifier	SCHWARZBECK	BBV9744	00246	2022.11.24	2023.11.23	\boxtimes

Test Report Number: BTF230815R00201



4 System test configuration

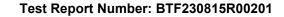
4.1 Test mode

During all testing, EUT is in link mode with base station emulator at maximum power level. The spurious emission measurements were carried out in semi-anechoic chamber with 3-meter test range, and EUT is rotated on three test planes to find out the worst emission.

Test modes					
Band	Radiated	Conducted			
LTE Band 2	■ QPSK link, 16QAM link	■ QPSK link, 16QAM link			
LTE Band 4	■ QPSK link, 16QAM link	■ QPSK link, 16QAM link			
LTE Band 5	■ QPSK link, 16QAM link	■ QPSK link, 16QAM link			
LTE Band 12	■ QPSK link, 16QAM link	■ QPSK link, 16QAM link			
LTE Band 66	■ QPSK link, 16QAM link	■ QPSK link, 16QAM link			

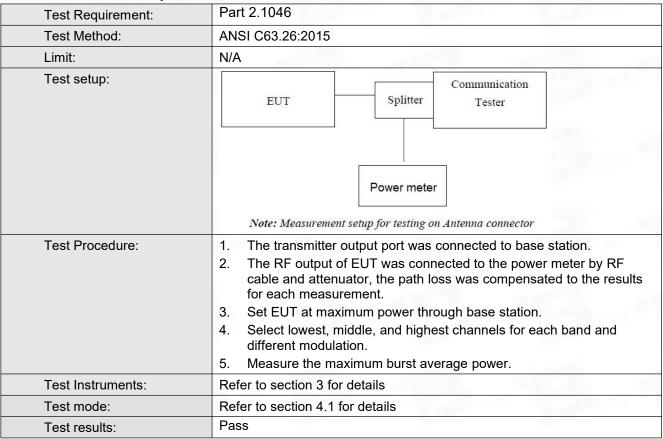
Note: Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas License Digital Systems v03r1 with maximum output power.

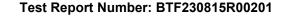
Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.





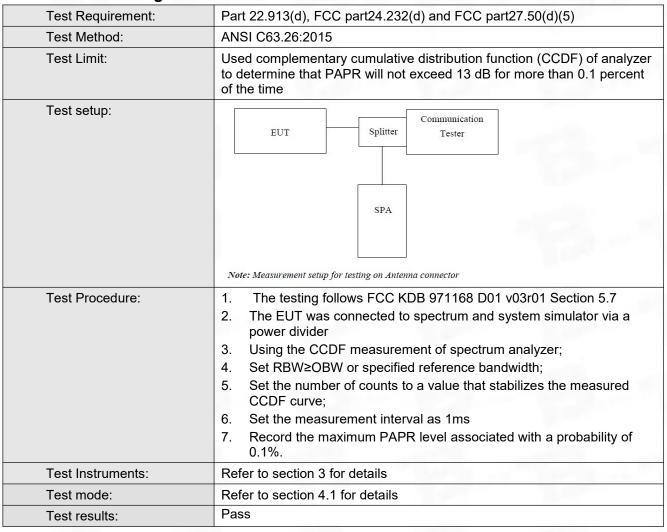
4.2 Conducted Output Power

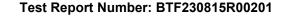






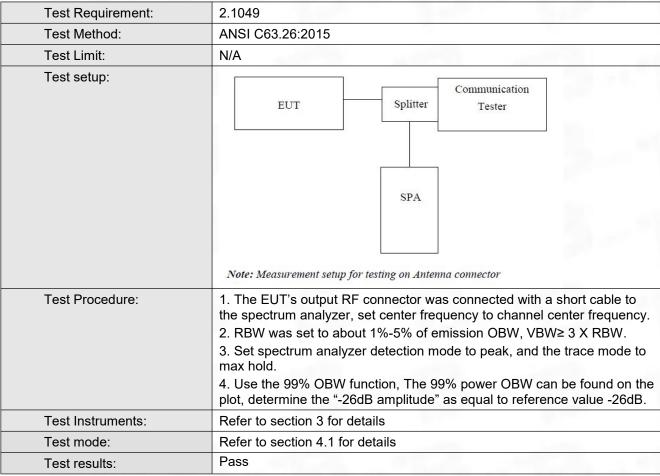
4.3 Peak-to-Average Ratio







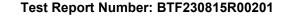
4.4 Occupied Bandwidth



Note: Please refer to Appendix A of the Appendix Test Data.

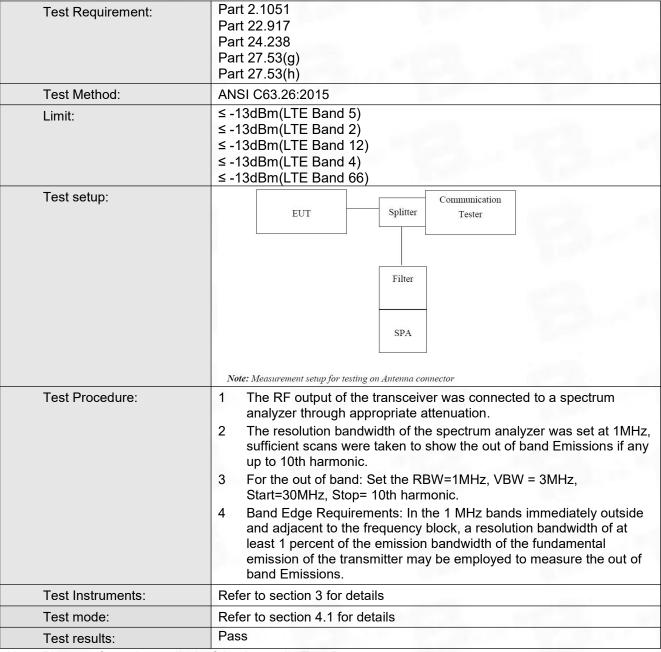
4.5 Modulation Characteristic

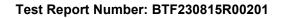
According to FCC § 2.1047(d), Part 24E & Part 27 there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.





4.6 Out of band emission at antenna terminals

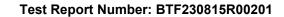






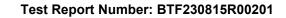
4.7 ERP. EIRP Measurement

Test Requirement:	Part 22.913(a), Part 24.232(c), Part 27.50(c), Part 27.50(d)
Test Method:	ANSI C63.26:2015
Limit:	ERP≤ 7W(38.45dBm) (LTE Band 5) EIRP≤ 2W(33.00dBm) (LTE Band 2) ERP≤ 3W(34.77dBm) (LTE Band 12) EIRP≤ 1W(30.00dBm) (LTE Band 4) EIRP≤ 1W(30.00dBm) (LTE Band 66)
Test setup:	Below 1GHz
	Antenna Tower Search Antenna RF T est Receiver Ground Plane Above 1GHz Antenna Tower Horn Antenna Spectrum Analyzer Amplifier
	Substituted method:
	Ground plane d: distance in meters d:3 meter I-4 meter Same AS EUT Height S.G. Substituted Dipole or Horn Antenna Bi-Log Antenna or Horn Antenna





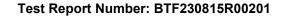
Test Procedure:	The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer.
	2. During the measurement, the EUT was communication with the station. The highest emission was recorded with the rotation of the turntable and the lowering of the test antenna from 4m to 1m. The reading was recorded and the field strength (E in dBuV/m) was calculated.
	3. ERP were measured using a substitution method. The EUT was replaced by dipole antenna connected, the S.G. output was recorded and ERP was calculated asfollows:
	ERP = S.G. output (dBm) + Antenna Gain (dBd) – Cable Loss (dB)
	4. EIRP were measured using a substitution method. The EUT was replaced by or horn antenna connected, the S.G. output was recorded and EIRP was calculated as follows:
	EIRP = S.G. output (dBm) + Antenna Gain (dBi) – Cable Loss (dB)
Test Instruments:	Refer to section 3 for details
Test mode:	Refer to section 4.1 for details
Test results:	Pass
Remark:	H,E1,E2 mean for EUT polarization of X, Y, Z



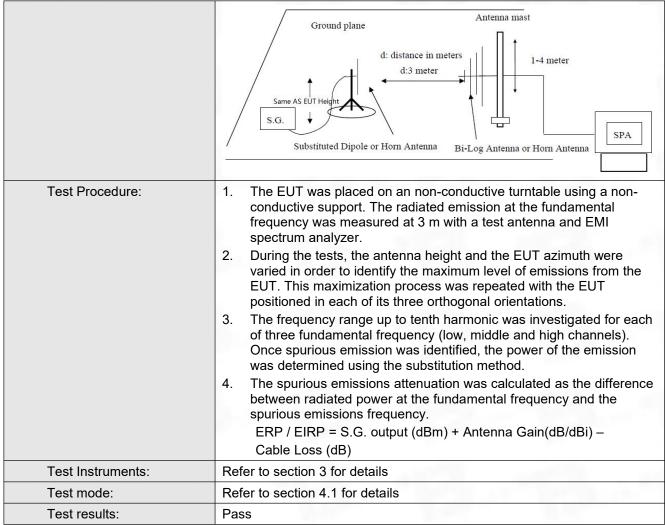


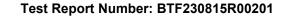
4.8 Field strength of spurious radiation measurement

4.8 Field strength of spurious radiation measurement		
Test Requirement:	Part 2.1053 Part 22.917 Part 24.238 Part 27.53(g) Part 27.53(h)	
Test Method:	ANSI C63.26:2015	
Limit:	≤ -13dBm(LTE Band 5) ≤ -13dBm(LTE Band 2) ≤ -13dBm(LTE Band 12) ≤ -13dBm(LTE Band 4) ≤ -13dBm(LTE Band 66)	
Test setup:	Below 1GHz Antenna Tower Search Antenna RF Test Receiver Ground Plane Above 1GHz Antenna Tower Horn Antenna Spectrum Analyzer Turn Table Substituted method:	
	Substituted method.	





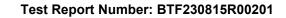






Frequency stability V.S. Temperature measurement

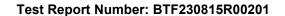
Test Requirement:	Part 2.1055(a)(1),(b) Part 22.355 Part 24.235 Part 27.54
Test Method:	ANSI C63.26:2015
Limit:	± 2.5 ppm(Part 22) Within the authorized bands of operation(Part 24, Part 27)
Test setup:	Spectrum analyzer EUT Att. Variable Power Supply
	Note: Measurement setup for testing on Antenna connector
Test procedure:	 The equipment under test was connected to an external DC power supply and input rated voltage. RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators. The EUT was placed inside the temperature chamber. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency. Turn EUT off and set the chamber temperature to -20°C. After the temperature stabilized for approximately 30 minutes recorded the frequency. Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached.
Test Instruments:	Refer to section 3 for details
Test mode:	Refer to section 4.1 for details
Test results:	Pass
Remark:	If all frequencies stability are comply with the lower limit, then all results can be considered qualified





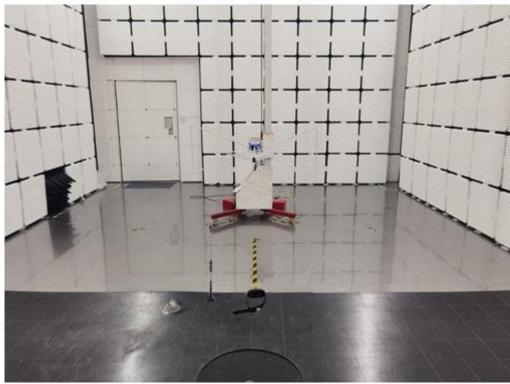
4.10 Frequency stability V.S. Voltage measurement

Test Requirement:	Part 2.1055(d)(1)(2) Part 22.355 Part 24.235 Part 27.54
Test Method:	ANSI C63.26:2015
Limit:	\pm 2.5ppm (part 22) Within the authorized bands of operation(Part 24, Part 27)
Test setup:	Temperature Chamber
	Spectrum analyzer EUT Att. Variable Power Supply
Test procedure:	 Note: Measurement setup for testing on Antenna connector Set chamber temperature to 20°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency. Reduce the input voltage to specified extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change.
Test Instruments:	Refer to section 3 for details
Test mode:	Refer to section 4.1 for details
Test results:	Pass
Remark:	Manufacturer specified the battery operating end point voltage is 3.4VDC, max voltage is 4.35VDC. If all frequencies stability are comply with the lower limit, then all results can be considered qualified





4.11 Test Setup Photo

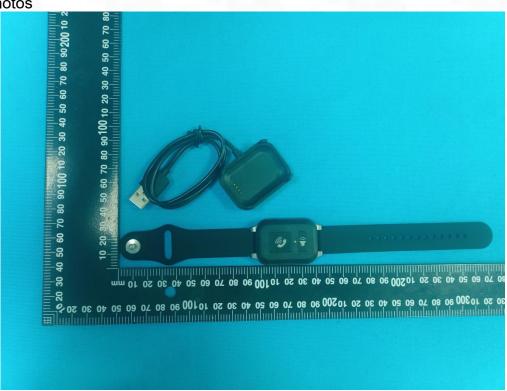


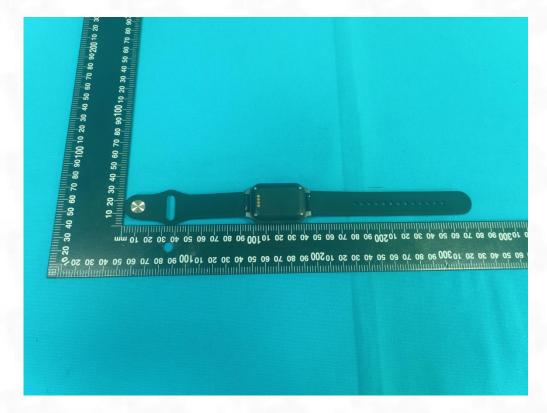


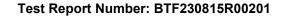
Test Report Number: BTF230815R00201



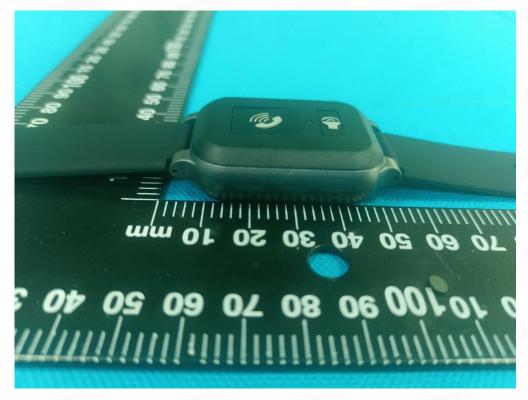
4.12 **EUT Photos**

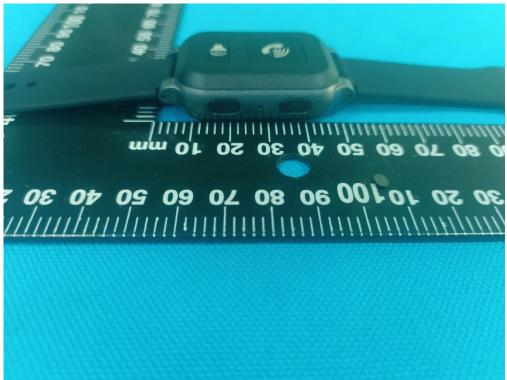






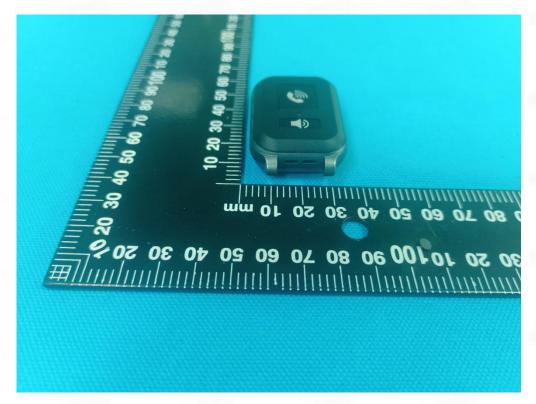


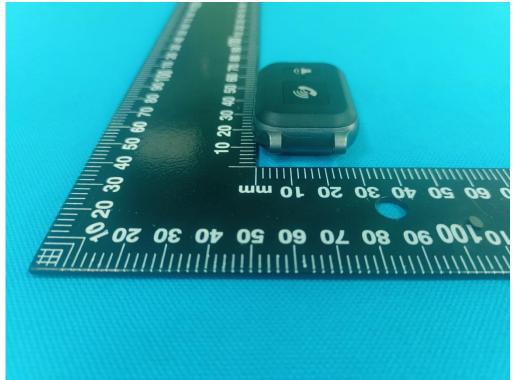


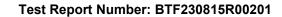




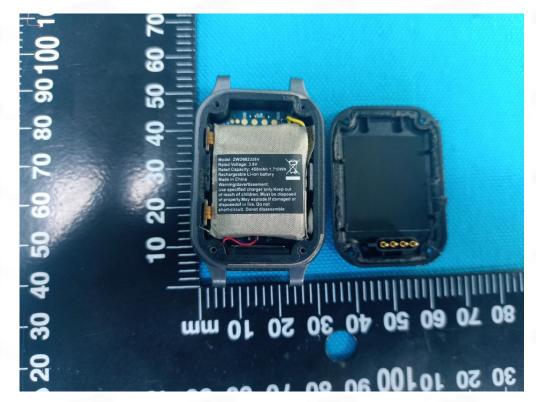


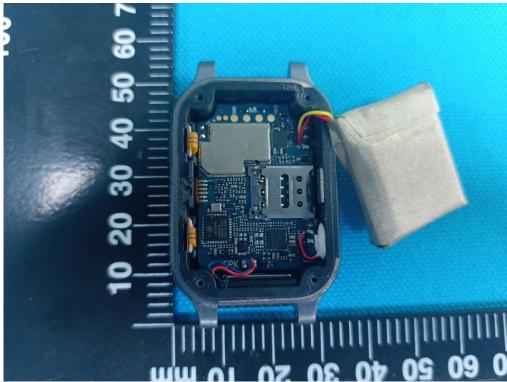


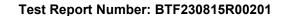






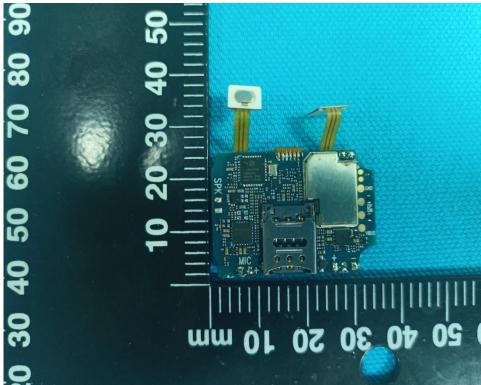


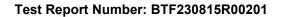




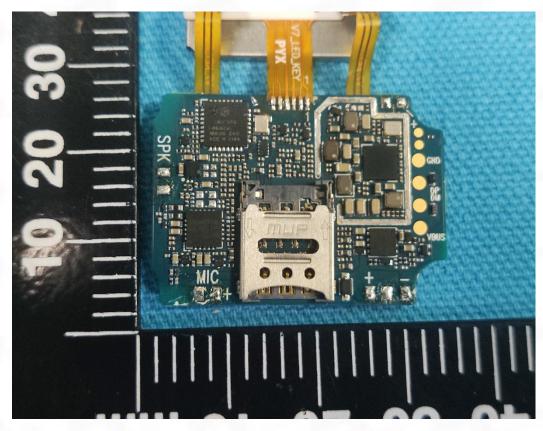


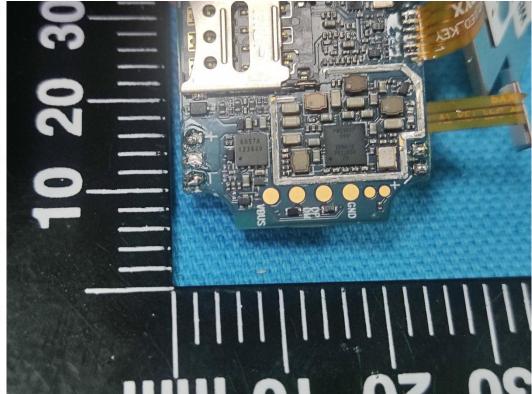


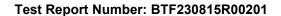




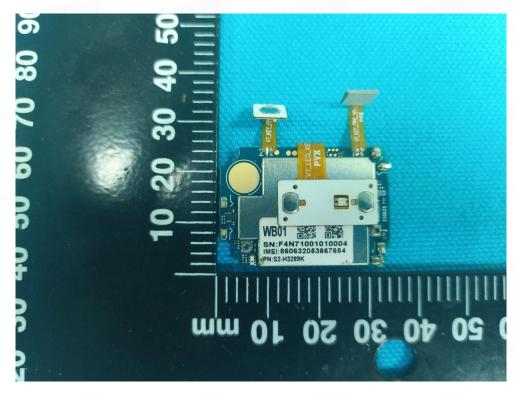


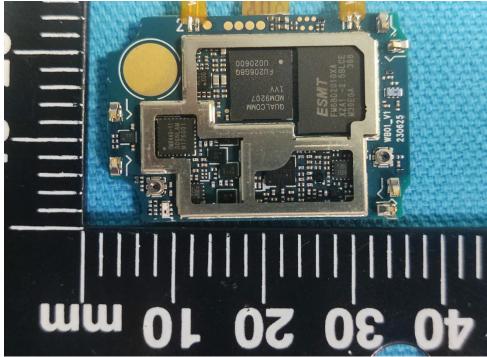


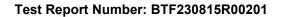




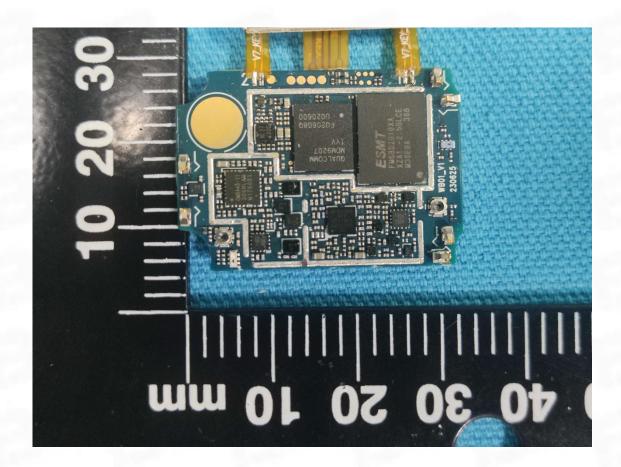


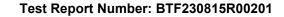
















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